

# Certificate of Analysis

**Stock#: US4011**

SWCNTs Array on Polycrystal Silicon, H: 100um

<b>Components</b>	<b>Contents (%)</b>
C	99.50
Al	0.02
Cl	0.02
Co	0.35
S	0.02

**Analysis Method: Energy Dispersive X-ray Spectroscopy**